

Notice of References Cited	Application/Control No. 10/526,771		Applicant(s)/Patent Under Reexamination ONISHI ET AL.	
	Examiner Ives Wu		Art Unit 1724	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,936,041	08-1999	Diana et al.	525/327.6
*	B	US-4,983,647	01-1991	Ueno et al.	523/220
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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